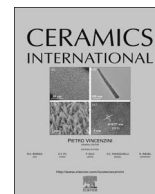




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Interfacial microstructure and mechanical properties of porous-Si₃N₄ ceramic and TiAl alloy joints vacuum brazed with AgCu filler

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ABSTRACT

Porous Si₃N₄ ceramic was firstly joined to TiAl alloy using an AgCu filler alloy. The effects of brazing temperature and holding time on the interfacial microstructure and mechanical properties of porous-Si₃N₄/AgCu/TiAl joints were studied. The typical interfacial microstructure of joints brazed at 880 °C for 15 min was TiAl/AlCu₂Ti/Ag-Cu eutectic/penetration layer (Ti₅Si₃+TiN, Si₃N₄, Ag (s, s), Cu (s, s))/porous-Si₃N₄. The penetration layer was formed firstly in the brazing process. With increasing brazing temperature and time, the thickness of the penetration layer increased. A large amount of element Ti was consumed in the penetration layer which suppressed the formation and growth of other intermetallic compounds. The penetration layer led the fracture to propagate in the porous Si₃N₄ ceramic substrate. The maximum shear strength was ~13.56 MPa.

1. Introduction

Ceramic-metal components have a wide application prospect. Among all the ceramics, silicon nitride (Si₃N₄) is regarded as one of the most promising ceramics due to its superior properties, such as high-temperature strength, good oxidation resistance, thermal-chemical corrosion resistance, and good dielectric property, etc. [1–3], and pore design of Si₃N₄ ceramic is demanded to decrease its density and dielectric constant in practical applications [4–6]. The porous Si₃N₄ ceramic possesses some beneficial properties in comparison to dense Si₃N₄, such as high specific surface area and good thermal shock resistance [7–9]. Therefore, porous-Si₃N₄ ceramics are considered as the next generation of radome materials. Meanwhile, TiAl intermetallics are well-known as promising alternative to titanium alloy in aerospace and automobile industry since they are featured with low density and high specific strength at elevated temperatures [10–13]. Hence, the porous Si₃N₄ ceramic-TiAl alloy component will be applied in different application widely, such as radome and antenna windows.

It is reported that ceramic-metal joints can be fabricated by transient liquid phase bonding, diffusion bonding, and active metal brazing techniques [14–16]. Brazing is one of the most important joining methods in the ceramic-metal manufacturing technologies. Recently, researches focused on the brazing of dense Si₃N₄ to metals

such as stainless steel, titanium alloys, and TiAl alloys [17–20]. AgCu based filler [21–25], Cu based filler [26–29] and Ni based filler alloy [30,31] were selected to braze Si₃N₄ ceramic to metals. Of the various active brazing alloys, Ag-Cu based alloys are the most common filler for their good wettability on Si₃N₄ ceramic and high bonding strength of the joints. As an active element, Ti is characterized as having sufficient thermodynamic driving force to destabilize the ionic or covalent bonding of the Si₃N₄ by reacting with it to form reaction layers. The formation of TiN and Ti₅Si₃ layers on the Si₃N₄ interface was reported [22,32]. It was also found that Ti not only obtained from the brazing filler, but also from the dissolution of the Ti-based metal substrate [33]. Furthermore, AgCu based filler alloys were also used in brazing TiAl alloy to non-metallic materials, such as, ZrO₂ ceramic [34,35], Al₂O₃ ceramic [36,37], SiC ceramic [38], C/SiC composites [39] and C/C composite [40]. However, the physicochemical properties of porous Si₃N₄ ceramic are quite different from the dense Si₃N₄ ceramic, such as low flexure strength, different coefficient of thermal expansion, thermal conductivity, etc. [41,42]. Consequently, the interfacial microstructure and joining strength of the joint brazed by porous Si₃N₄ ceramic and TiAl alloy will be definitely distinguishing.

In this work, porous Si₃N₄ was firstly joined to TiAl alloy using the traditional AgCu eutectic brazing alloy. The effect of porous structure and brazing parameters were studied in comparison with our previous

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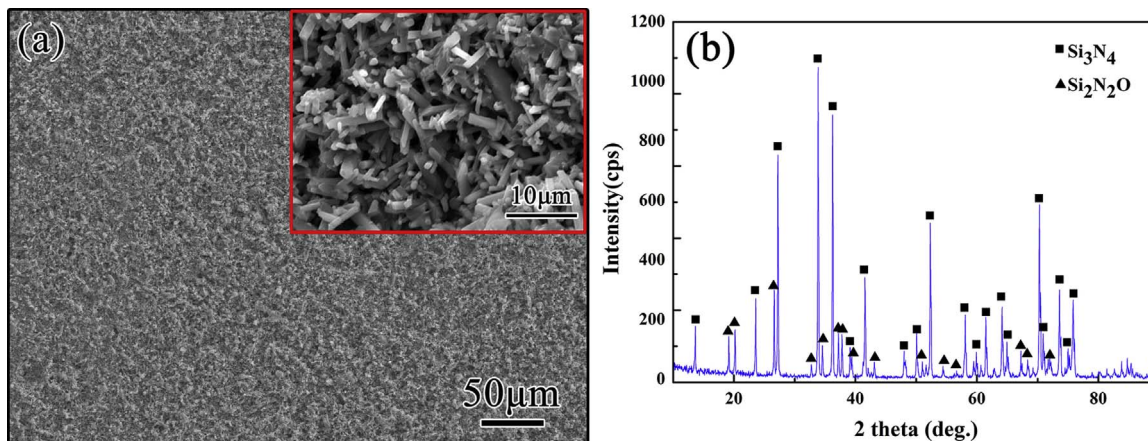


Fig. 1. (a) SEM micrograph of the ceramic; (b) XRD patterns of the ceramic.

work. Especially, the particular penetration layer was formed due to the diffusion and reaction of molten filler into porous ceramic. The influences of brazing parameters on the interfacial microstructure and mechanical properties were analyzed in details.

2. Materials and methods

The porous- Si_3N_4 ceramics with a porosity of 43% used in this work were hot-pressed by $\beta\text{-Si}_3\text{N}_4$ powder. Fig. 1 shows the morphology and the XRD pattern of the porous- Si_3N_4 ceramic substrate. The raw ceramics were cut into blocks with the dimension of $5\text{ mm}\times 5\text{ mm}\times 5\text{ mm}$ using a diamond cutting machine. The dimension of TiAl (Ti-46Al-2Cr-2Nb) specimens was $10\text{ mm}\times 5\text{ mm}\times 3\text{ mm}$. The brazing filler alloy adopted in this study was commercial AgCu eutectic filler alloy (Ag-28Cu) powder within $50\text{ }\mu\text{m}$.

Brazing procedures were performed in a vacuum furnace with a vacuum of $1.3\text{--}2.0\times 10^{-3}\text{ Pa}$. The brazing surfaces of the porous- Si_3N_4 ceramic and TiAl samples were ground on SiC grit papers prior to joining and then polished by diamond pastes. All of the polished samples were ultrasonically cleaned in acetone and dried by air blowing. The filler alloy powder for $100\text{ }\mu\text{m}$ thickness was placed between the brazing couples. The schematic illustration of the brazed joint is shown in Fig. 2. For vacuum brazing experiments with brazing temperature between $840\text{ }^\circ\text{C}$ and $920\text{ }^\circ\text{C}$, holding time ranged from 0 min to 20 min. A 10 min dwell period was incorporated into the brazing cycle on heating to $750\text{ }^\circ\text{C}$, to help reduce any temperature gradients across the components. The joining process was as the following: first heated to $750\text{ }^\circ\text{C}$ at a rate of $20\text{ }^\circ\text{C}/\text{min}$, and then, the temperature continued to increase to the brazing temperature at a rate of $10\text{ }^\circ\text{C}/\text{min}$. Subsequently, the brazing specimens were cooled down to $400\text{ }^\circ\text{C}$ at a rate of $5\text{ }^\circ\text{C}/\text{min}$. During the brazing process, a pressure of about 0.05 MPa was applied to ensure the surface of couples contact closely.

The cross-sections of joints were characterized by a field emission scanning electron microscope (FESEM, MERLIN Compact, ZEISS)

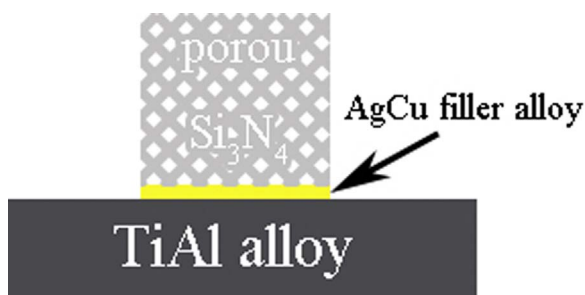


Fig. 2. Schematic illustration of the porous- $\text{Si}_3\text{N}_4/\text{AgCu}/\text{TiAl}$ brazed joint.

equipped with an energy dispersive spectrometer (EDS, OCTANE PLUS, EDAX) to monitor the homogeneity of the interfacial morphology and chemistry across the joint. Samples for SEM analysis were mounted in an acrylic polymer at room temperature, polished using standard metallographic techniques and finally coated with a thin layer of Au. The reaction phases at the interface were identified using an X-ray diffraction (XRD, DX-2700) spectrometer equipped with Cu K α radiation. The room temperature shear tests were performed at a constant speed of $0.5\text{ mm}/\text{min}$ using a universal testing machine (Instron 5967). For each set of experimental data, at least five samples were used to average to joint strength. The optical digital microscope (DSX 510, OLMPUS) was used to observe the fracture surface of the joint after shear test.

3. Results and discussions

3.1. Microstructures characterization of the porous- $\text{Si}_3\text{N}_4/\text{AgCu}/\text{TiAl}$ joints

Fig. 3 shows the typical microstructure and elemental distribution of the porous- $\text{Si}_3\text{N}_4/\text{AgCu}/\text{TiAl}$ joint brazed at $880\text{ }^\circ\text{C}/15\text{ min}$. As shown in Fig. 3(a), the brazed joint can be divided into three zones: Zone I (reaction zone adjacent to TiAl substrate), Zone II (brazing seam) and Zone III (penetration layer). According to the element distribution results shown in Fig. 3(b-f), Zone I was a reaction layer adjacent to TiAl substrate which mainly contained of elements Ti, Al, Cu; and element Ag, Cu distributed in the Zone II in form of typical Ag-Cu eutectic structure; in addition to the porous Si_3N_4 ceramic substrate Zone III mainly composed of element Ag, Cu, and Ti. It should be noted that element Ti in Zone III was gradient distribution in the direction perpendicular to the porous Si_3N_4 ceramic.

In order to investigate the microstructure of the joints in details, high magnified interfacial microstructures of Zone I-III are shown in Fig. 4, and the EDS chemical compositions of each spot in Fig. 4 are listed in Table 1. The dark gray phase in Zone I was a strip, distributing with the directionality, and primarily consisted of Al, Cu, and Ti, which could be considered as AlCu_2Ti intermetallics [43]. Occasionally, small quantities of AlCu_2Ti were found between TiAl and AlCu_2Ti layer which was marked as A in Fig. 4(a). According to the Al-Cu-Ti ternary alloy phase diagram and the reaction schemes shown in Fig. 5 [44], the peritectic reaction $\text{P}_2\text{:L}+\text{TiAl}+\text{Ti}_3\text{Al}\rightarrow\text{AlCu}_2\text{Ti}$ happened for the low content of Cu, and the AlCu_2Ti layer was formed by the reaction $\text{e}_2\text{:L}\rightarrow\text{AlCu}_2\text{Ti}+(\text{Cu})$. The white phase marked as C and light gray phase marked as D in Fig. 4(b) were Ag based solid solution and Cu based solid solution respectively. Meanwhile, the reaction between Ti dissolved from the TiAl substrate and porous Si_3N_4 ceramic was not only carried out on the ceramic surface but also in the porous structures.

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